

# FMBT3904

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# FMBT3904

## 200mA Silicon NPN Epitaxial Planar Transistor

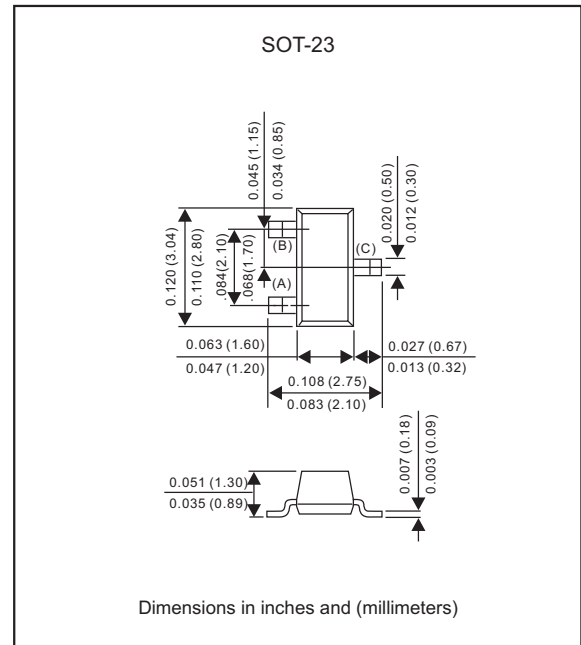
### Features

- High collector-emitterbreakdien voltage. ( $BV_{CEO} = 40V@I_C=1mA$ )
- Small load switch transistor with high gain and low stauration voltage, is designed for general purpose amflifier and switching applications at collector current.
- Capable of 225mW power dissipation.
- Lead-free parts for green partner, exceeds environmental standards of MIL-STD-19500 /228
- Suffix "-H" indicates Halogen free part, ex. FMBT3904-H.

### Mechanical data

- Epoxy:UL94-V0 rated flame retardant
- Case : Molded plastic, SOT-23
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026
- Mounting Position : Any
- Weight : Approximated 0.008 gram

### Package outline



### Maximum ratings (AT $T_A=25^{\circ}C$ unless otherwise noted)

PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Collector-Base voltage		$V_{CBO}$			60	V
Collector-Emitter voltage		$V_{CEO}$			40	V
Emitter-Base voltage		$V_{EBO}$			6.0	V
Collector current		$I_C$			200	mA
Total device dissipation FR-5 board (1)	$T_A = 25^{\circ}C$	$P_D$			225	mW
	Derate above $25^{\circ}C$	$P_D$			1.8	mW/ $^{\circ}C$
Thermal resistance	Junction to ambient	$R_{BJA}$			556	$^{\circ}C/W$
Total device dissipation alumina substrate(2)	$T_A = 25^{\circ}C$	$P_D$			300	mW
	Derate above $25^{\circ}C$	$P_D$			2.4	mW/ $^{\circ}C$
Thermal resistance	Junction to ambient	$R_{BJA}$			417	$^{\circ}C/W$
Operating temperature		$T_J$	-55		+150	$^{\circ}C$
Storage temperature		$T_{STG}$	-65		+150	

1.FR-5 = 1.0 X 0.75 X0.062 in.

2.Alumina = 0.4 X 0.3 X 0.024 in. 99.5% alumina.

## FMBT3904

**Characteristics** (AT  $T_A=25^\circ\text{C}$  unless otherwise noted)**Off characteristics**

PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Collector-Base breakdown voltage	$I_C = 10\mu\text{A}, I_E = 0$	$V_{(BR)CBO}$	60			V
Collector-Emitter breakdown voltage(3)	$I_C = 1\text{mA}, I_B = 0$	$V_{(BR)CEO}$	40			V
Emitter-Base breakdown voltage	$I_E = 10\mu\text{A}, I_C = 0$	$V_{(BR)EBO}$	6.0			V
Base cutoff current	$V_{CE} = 30\text{V}, V_{EB} = 3.0\text{V}$	$I_{BL}$			50	nA
Collector cutoff current	$V_{CE} = 30\text{V}, V_{EB} = 3.0\text{V}$	$I_{CEX}$			50	

**On characteristics(3)**

PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
DC current gain	$I_C = 0.1\text{mA}, V_{CE} = 1.0\text{V}$	$h_{FE}$	40			-
	$I_C = 1.0\text{mA}, V_{CE} = 1.0\text{V}$		70			
	$I_C = 10\text{mA}, V_{CE} = 1.0\text{V}$		100		300	
	$I_C = 50\text{mA}, V_{CE} = 1.0\text{V}$		60			
	$I_C = 100\text{mA}, V_{CE} = 1.0\text{V}$		30			
Collector-Emitter saturation voltage(3)	$I_C = 10\text{mA}, I_B = 1.0\text{mA}$	$V_{CE(sat)}$			0.2	V
	$I_C = 50\text{mA}, I_B = 5.0\text{mA}$				0.3	
Base-Emitter saturation voltage(3)	$I_C = 10\text{mA}, I_B = 1.0\text{mA}$	$V_{BE(sat)}$	0.65		0.85	V
	$I_C = 50\text{mA}, I_B = 5.0\text{mA}$				0.95	

3. Pulse test : pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2.0\%$ .

**Small-signal characteristics**

PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Current-gain-bandwidth product	$I_C = 10\text{mA}, V_{CE} = 20\text{V}, f = 100\text{MHz}$	$f_T$	300			MHz
Output capacitance	$V_{CB} = 5.0\text{V}, I_E = 0, f = 1.0\text{MHz}$	$C_{obo}$			4.0	pF
Input capacitance	$V_{EB} = 0.5\text{V}, I_C = 0, f = 1.0\text{MHz}$	$C_{ibo}$			8.0	pF
Input impedance	$V_{CE} = 10\text{V}, I_C = 1.0\text{mA}, f = 1.0\text{KHz}$	$h_{ie}$	1.0		10	kohms
Voltage feedback ratio	$V_{CE} = 10\text{V}, I_C = 1.0\text{mA}, f = 1.0\text{KHz}$	$h_{fe}$	0.5		8.0	$\times 10^{-4}$
Small-signal current gain	$V_{CE} = 10\text{V}, I_C = 1.0\text{mA}, f = 1.0\text{KHz}$	$h_{fe}$	100		400	-
Output admittance	$V_{CE} = 10\text{V}, I_C = 1.0\text{mA}, f = 1.0\text{KHz}$	$h_{oe}$	1.0		40	umhos
Noise figure	$V_{CE} = 5.0\text{V}, I_C = 100\mu\text{A}, R_s = 1.0\text{K ohms}, f = 1.0\text{KHz}$	NF			5.0	dB

**Switching characteristics**

PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Delay time	$V_{CC} = 3.0\text{V}, V_{BE} = -0.5\text{V}, I_C = 10\text{mA}, I_{B1} = 1.0\text{mA}$	$t_d$			35	ns
Rise time		$t_r$			35	
Storage time	$V_{CC} = 3.0\text{V}, I_C = 10\text{mA}, I_{B1} = I_{B2} = 1.0\text{mA}$	$t_s$			200	
Fall time		$t_f$			50	

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## Switching time equivalent test circuits

Figure 1. Delay and Rise Time Equivalent Test Circuit

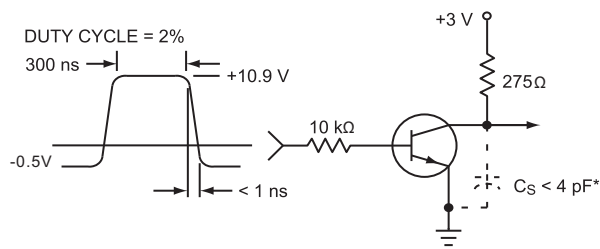
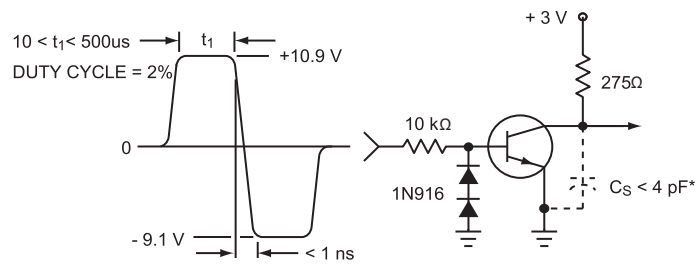


Figure 2. Storage and Fall Time Equivalent Test Circuit



\* Total shunt capacitance of test jig and connectors

# TYPICAL TRANSIENT CHARACTERISTICS

Figure 3. Capacitance

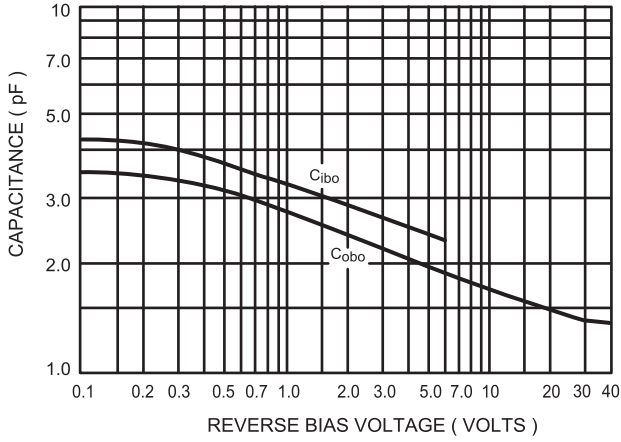


Figure 4. Charge Data

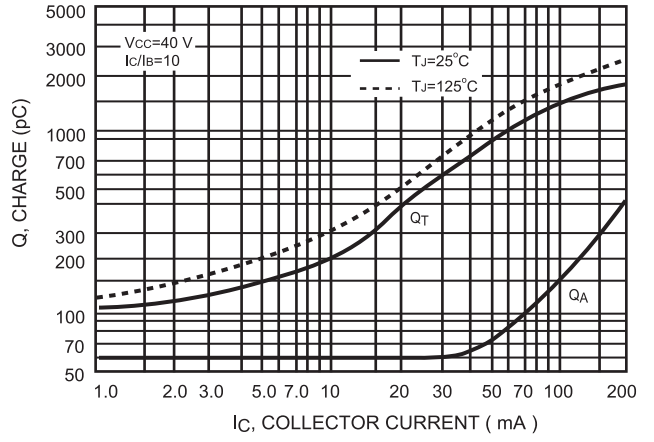


Figure 5. Turn-On Time

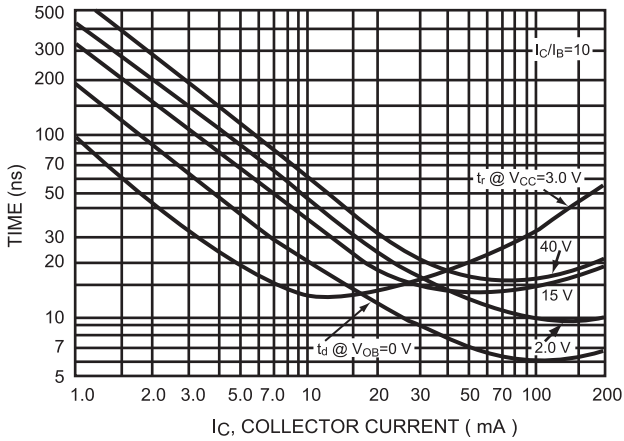


Figure 6. Rise Time

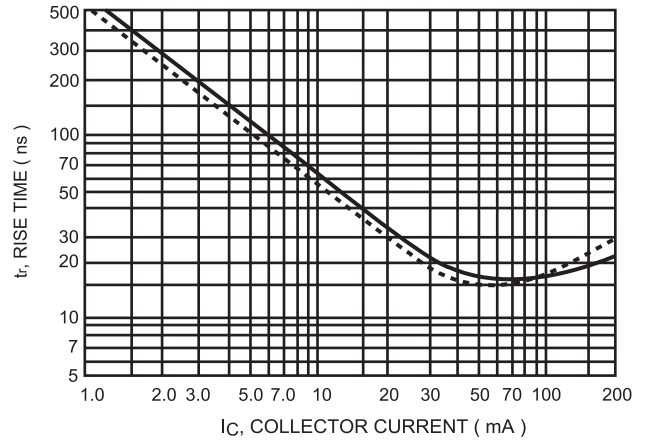


Figure 7. Storage Time

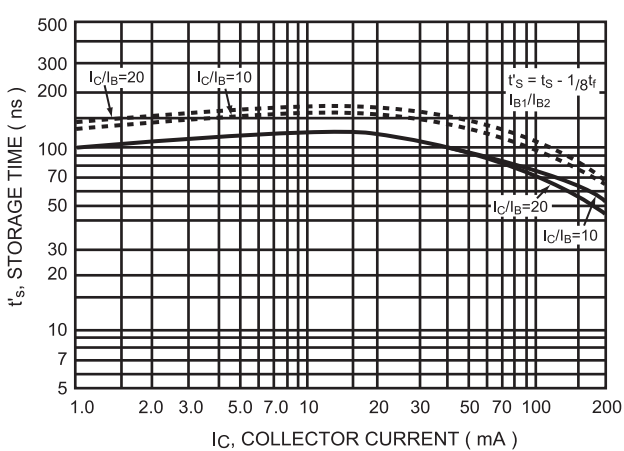
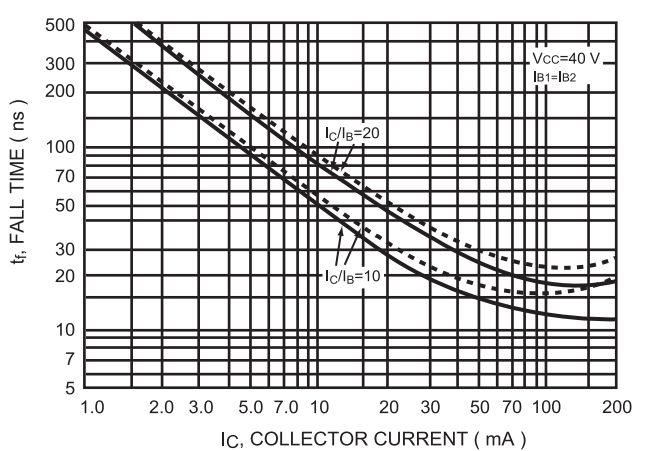


Figure 8. Fall Time



# TYPICAL AUDIO SMALL-SIGNAL CHARACTERISTICS NOISE FIGURE VARIATIONS

(VCE=5.0 V, TA=25 °C, Bandwidth=1.0Hz)

Figure 9.

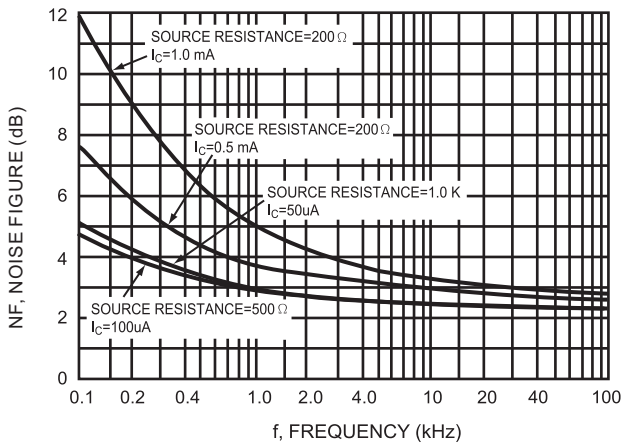
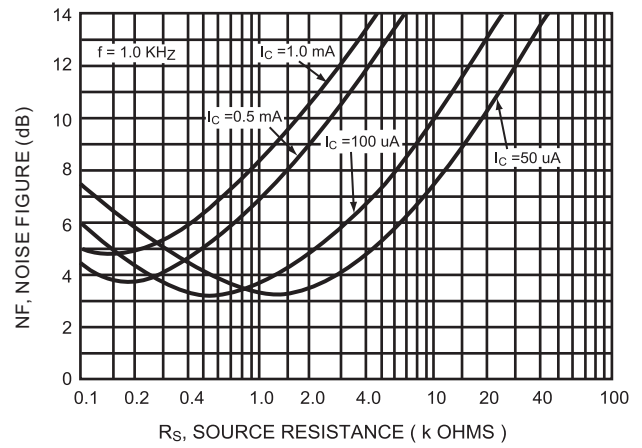


Figure 10.



## h PARAMETERS

(VCE=10 V, f=1.0 kHz, TA=25 °C)

Figure 11. Current Gain

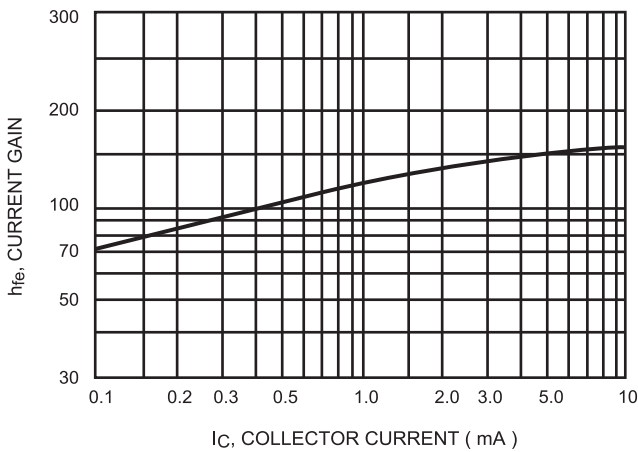


Figure 12. Output Admittance

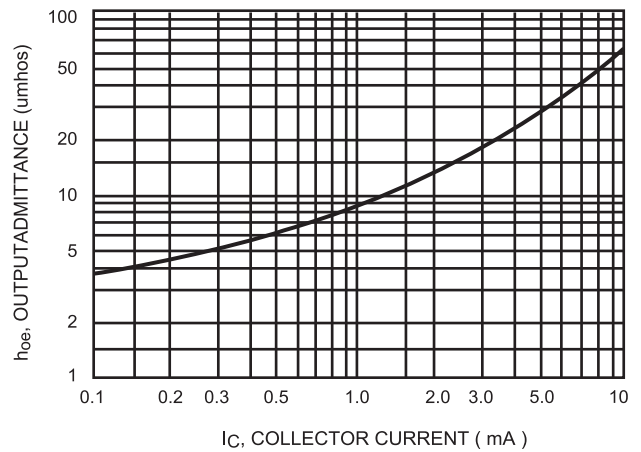


Figure 13. Input Impedance

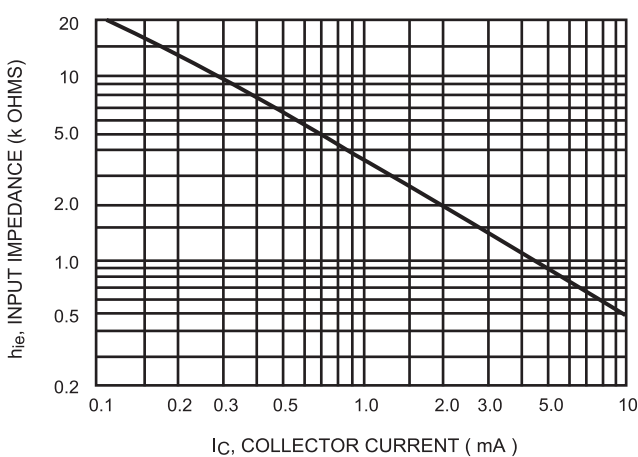
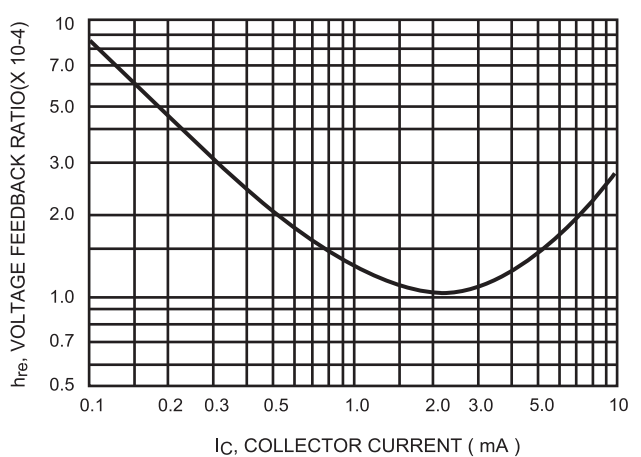


Figure 14. Voltage Feedback Ratio



# TYPICAL STATIC CHARACTERISTICS

Figure 15. DC Current Gain

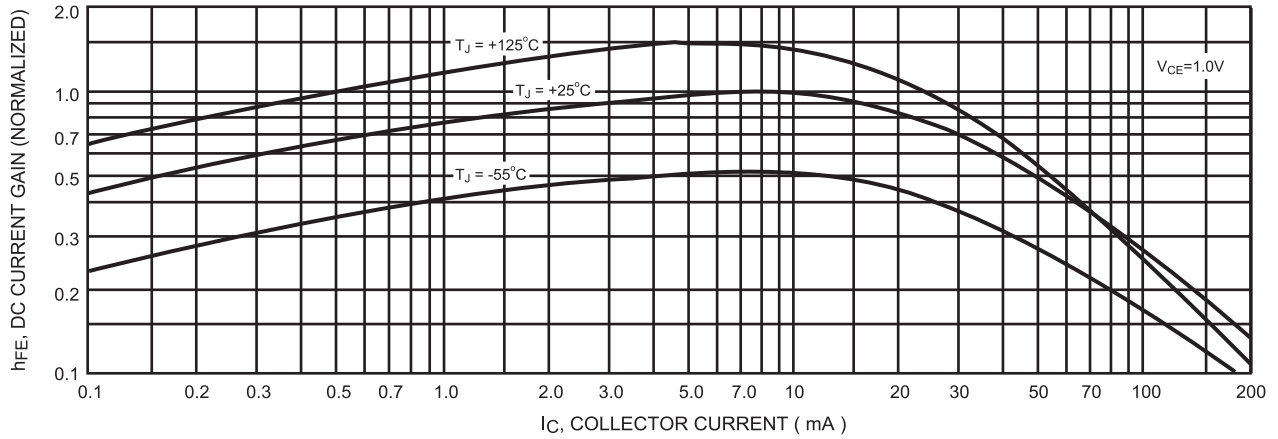


Figure 16. Collector Saturation Region

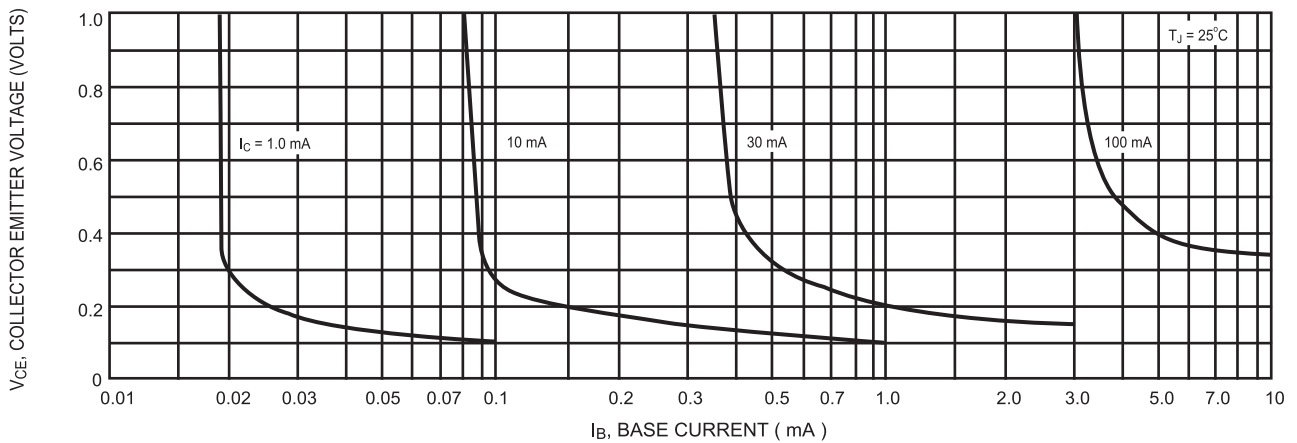


Figure 17. " ON " Voltage

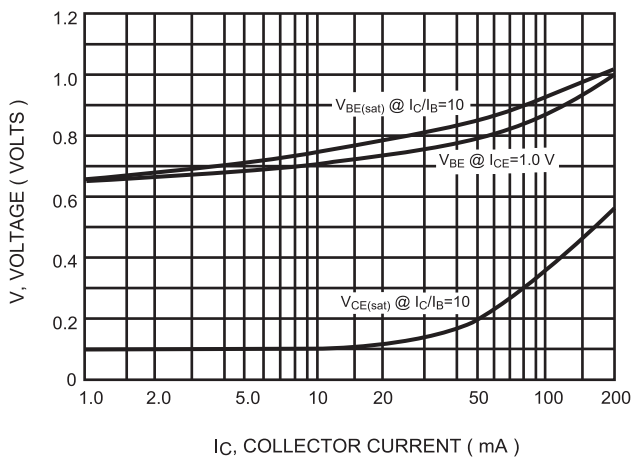
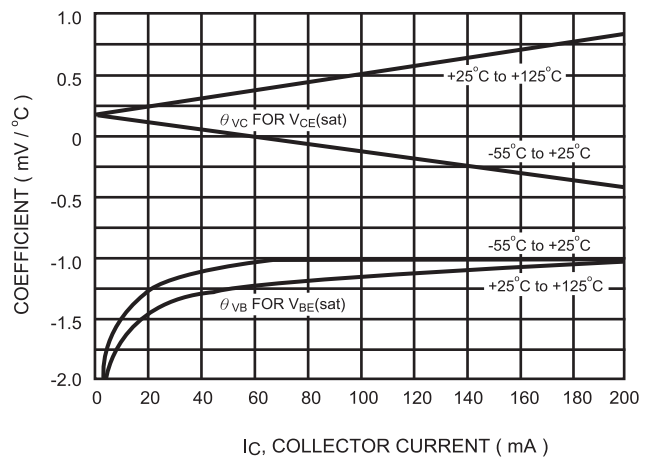
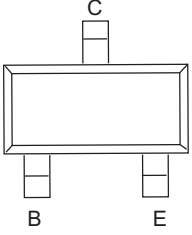
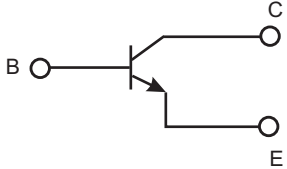


Figure 18. Temperature Coefficients



# FMBT3904

## Pinning information

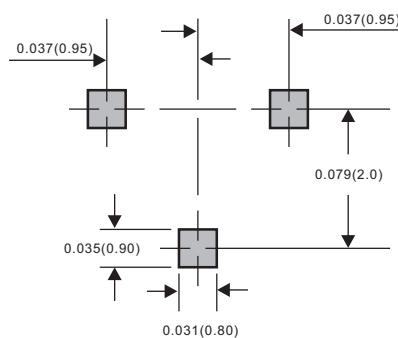
Pin	Simplified outline	Symbol
PinB Base PinC Collector PinE Emitter		

## Marking

Type number	Marking code
FMBT3904	1AM
	LF
	K1N

## Suggested solder pad layout

### SOT-23

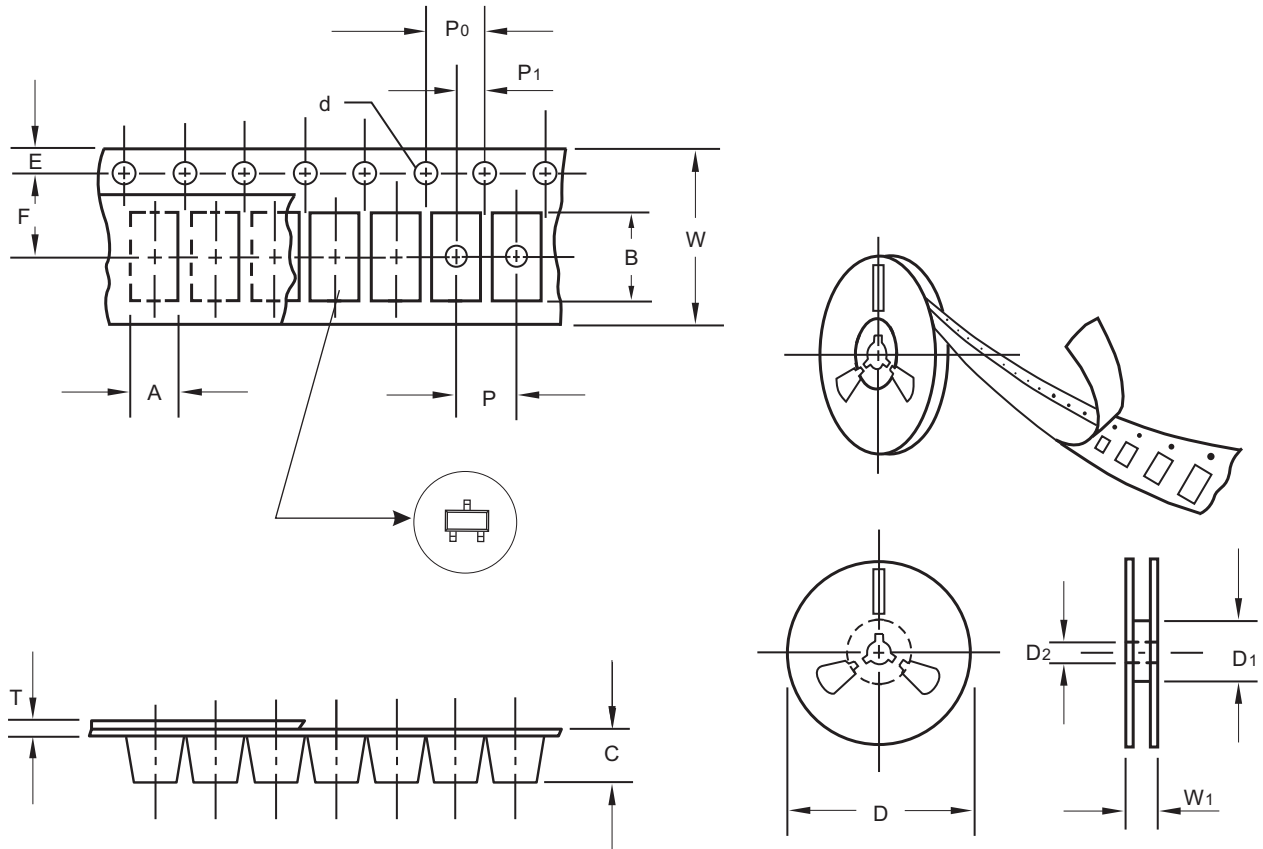


Dimensions in inches and (millimeters)



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## Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.1	3.15
Carrier length	B	0.1	2.77
Carrier depth	C	0.1	1.22
Sprocket hole	d	0.1	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	55.00
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W1	1.0	12.0

Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

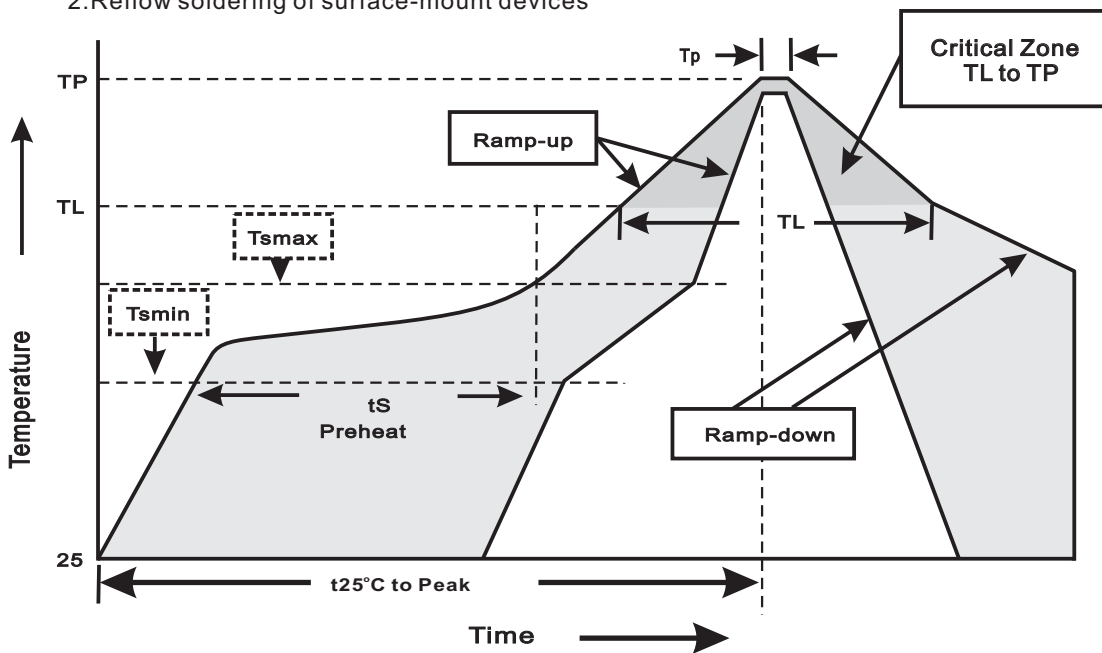
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## Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)	APPROX. GROSS WEIGHT (kg)
SOT-23	7"	3,000	4.0	30,000	183*183*123	178	382*262*387	240,000	11.6

## Suggested thermal profiles for soldering processes

- 1.Storage environment: Temperature=5°C~40°C Humidity=55%±25%
- 2.Reflow soldering of surface-mount devices



### 3.Reflow soldering

Profile Feature	Soldering Condition
Average ramp-up rate(T <sub>L</sub> to T <sub>P</sub> )	<3°C/sec
Preheat -Temperature Min(T <sub>smmin</sub> ) -Temperature Max(T <sub>smmax</sub> ) -Time(min to max)(t <sub>s</sub> )	150°C 200°C 60~120sec
T <sub>smmax</sub> to T <sub>L</sub> -Ramp-upRate	<3°C/sec
Time maintained above: -Temperature(T <sub>L</sub> ) -Time(t <sub>L</sub> )	217°C 60~260sec
Peak Temperature(T <sub>P</sub> )	255°C-0/+5°C
Time within 5°C of actual Peak Temperature(t <sub>P</sub> )	10~30sec
Ramp-down Rate	<6°C/sec
Time 25°C to Peak Temperature	<6minutes

**FMBT3904****High reliability test capabilities**

Item Test	Conditions
1. Steady State Operating Life	$P_o=225\text{mW}$ Test Duration:1000hrs
2. High Temperature Reverse Bias	$T_j=150^\circ\text{C}$ , $V_{ce}=80\%$ related volage, 1000hrs
3. Temperature Cycle	$-55^\circ\text{C}(15\text{min})$ to $150^\circ\text{C}(15\text{min})$ Air to Air Transition Time<20sec Test Cycles: 1000cycle
4. Autoclave	$P=2\text{atm}$ $T_a=121^\circ\text{C}$ $\text{RH}=100\%$ Test Duration: 96hrs
5. High Temperature Storage Life	$T_a=150^\circ\text{C}$ Test Duration: 1000hrs
6. Solderability	$245^\circ\text{C}$ ,5sec
7. High Temperature High Humidity Reverse Bias	$T_a=85^\circ\text{C}$ , 85%RH, $V_{ce}=80\%$ related volage, 1000hrs
8. Resistance to Soldering Heat	$260^\circ\text{C}$ ,10sec